

# FDS6990AS

## Dual 30V N-Channel PowerTrench® SyncFET™

### Features

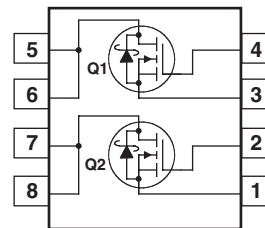
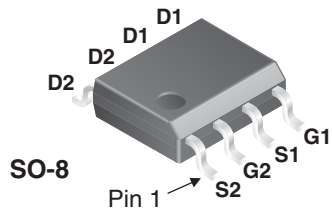
- 7.5 A, 30 V.  $R_{DS(ON)} = 22\text{ m}\Omega @ V_{GS} = 10\text{ V}$   
 $R_{DS(ON)} = 28\text{ m}\Omega @ V_{GS} = 4.5\text{ V}$
- Includes SyncFET Schottky diode
- Low gate charge (10nC typical)
- High performance trench technology for extremely low  $R_{DS(ON)}$
- High power and current handling capability

### General Description

The FDS6990AS is designed to replace a dual SO-8 MOSFET and two Schottky diodes in synchronous DC:DC power supplies. This 30V MOSFET is designed to maximize power conversion efficiency, providing a low  $R_{DS(ON)}$  and low gate charge. Each MOSFET includes integrated Schottky diodes using Fairchild's monolithic SyncFET technology. The performance of the FDS6990AS as the low-side switch in a synchronous rectifier is similar to the performance of the FDS6990A in parallel with a Schottky diode.

### Applications

- DC/DC converter
- Motor drives



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Symbol                         | Parameter   | Ratings         | Units              |     |
|--------------------------------|---|-----------------|--------------------|-----|
| $V_{DSS}$                      | Drain-Source Voltage                              | 30              | V                  |     |
| $V_{GSS}$                      | Gate-Source Voltage                               | $\pm 20$        | V                  |     |
| $I_D$                          | Drain Current – Continuous (Note 1a)              | 7.5             | A                  |     |
|                                |   | 20              |                    |     |
| $P_D$                          | Power Dissipation for Dual Operation              | 2               | W                  |     |
|                                | Power Dissipation for Single Operation (Note 1a)  | 1.6             |                    |     |
|                                |   | (Note 1b)       |                    | 1   |
|                                |   | (Note 1c)       |                    | 0.9 |
| $T_J, T_{STG}$                 | Operating and Storage Junction Temperature Range  | $-55$ to $+150$ | $^\circ\text{C}$   |     |
| <b>Thermal Characteristics</b> |   |                 |                    |     |
| $R_{\theta JA}$                | Thermal Resistance, Junction-to-Ambient (Note 1a) | 78              | $^\circ\text{C/W}$ |     |
| $R_{\theta JC}$                | Thermal Resistance, Junction-to-Case (Note 1)     | 40              | $^\circ\text{C/W}$ |     |

### Package Marking and Ordering Information

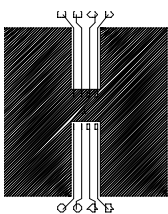
| Device Marking | Device                | Reel Size | Tape width | Quantity   |
|----------------|-----------------------|-----------|------------|------------|
| FDS6990AS      | FDS6990AS             | 13"       | 12mm       | 2500 units |
| FDS6990AS      | FDS6990AS_NL (Note 4) | 13"       | 12mm       | 2500 units |

**Electrical Characteristics**  $T_A = 25^\circ\text{C}$  unless otherwise noted

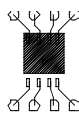
| Symbol  | Parameter   | Test Conditions  | Min | Typ            | Max            | Units                      |
|---|---|--|-----|----------------|----------------|----------------------------|
| <b>Off Characteristics</b>                                    |   |  |     |                |                |                            |
| $BV_{DSS}$  | Drain–Source Breakdown Voltage                        | $V_{GS} = 0\text{ V}, I_D = 1\text{ mA}$   | 30  |                |                | V                          |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$                          | Breakdown Voltage Temperature Coefficient             | $I_D = 1\text{ mA}$ , Referenced to $25^\circ\text{C}$   |     | 31             |                | $\text{mV}/^\circ\text{C}$ |
| $I_{DSS}$   | Zero Gate Voltage Drain Current                       | $V_{DS} = 24\text{ V}, V_{GS} = 0\text{ V}$  |     |                | 500            | $\mu\text{A}$              |
| $I_{GSS}$   | Gate–Body Leakage                                     | $V_{GS} = \pm 20\text{ V}, V_{DS} = 0\text{ V}$  |     |                | $\pm 100$      | nA                         |
| <b>On Characteristics (Note 2)</b>                            |   |  |     |                |                |                            |
| $V_{GS(th)}$  | Gate Threshold Voltage                                | $V_{DS} = V_{GS}, I_D = 1\text{ mA}$   | 1   | 1.7            | 3              | V                          |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$                        | Gate Threshold Voltage Temperature Coefficient        | $I_D = 1\text{ mA}$ , Referenced to $25^\circ\text{C}$   |     | –3             |                | $\text{mV}/^\circ\text{C}$ |
| $R_{DS(on)}$  | Static Drain–Source On–Resistance                     | $V_{GS} = 10\text{ V}, I_D = 7.5\text{ A}$<br>$V_{GS} = 10\text{ V}, I_D = 7.5\text{ A}, T_J = 125^\circ\text{C}$<br>$V_{GS} = 4.5\text{ V}, I_D = 6.5\text{ A}$ |     | 17<br>26<br>21 | 22<br>35<br>28 | $\text{m}\Omega$           |
| $I_{D(on)}$   | On–State Drain Current                                | $V_{GS} = 10\text{ V}, V_{DS} = 5\text{ V}$  | 20  |                |                | A                          |
| $g_{FS}$  | Forward Transconductance                              | $V_{DS} = 15\text{ V}, I_D = 10\text{ A}$  |     | 29             |                | S                          |
| <b>Dynamic Characteristics</b>                                |   |  |     |                |                |                            |
| $C_{iss}$   | Input Capacitance                                     | $V_{DS} = 15\text{ V}, V_{GS} = 0\text{ V},$<br>$f = 1.0\text{ MHz}$   |     | 550            |                | pF                         |
| $C_{oss}$   | Output Capacitance                                    |  |     | 330            |                | pF                         |
| $C_{rss}$   | Reverse Transfer Capacitance                          |  |     | 60             |                | pF                         |
| $R_G$   | Gate Resistance                                       | $V_{GS} = 15\text{ mV}, f = 1.0\text{ MHz}$  |     | 3.1            |                | $\Omega$                   |
| <b>Switching Characteristics (Note 2)</b>                     |   |  |     |                |                |                            |
| $t_{d(on)}$   | Turn–On Delay Time                                    | $V_{DS} = 15\text{ V}, I_D = 1\text{ A},$<br>$V_{GS} = 10\text{ V}, R_{GEN} = 6\ \Omega$   |     | 8              | 16             | ns                         |
| $t_r$   | Turn–On Rise Time                                     |  |     | 5              | 10             | ns                         |
| $t_{d(off)}$  | Turn–Off Delay Time                                   |  |     | 24             | 38             | ns                         |
| $t_f$   | Turn–Off Fall Time                                    |  |     | 4              | 88             | ns                         |
| $t_{d(on)}$   | Turn–On Delay Time                                    | $V_{DS} = 15\text{ V}, I_D = 1\text{ A},$<br>$V_{GS} = 4.5\text{ V}, R_{GEN} = 6\ \Omega$  |     | 9              | 18             | ns                         |
| $t_r$   | Turn–On Rise Time                                     |  |     | 8              | 16             | ns                         |
| $t_{d(off)}$  | Turn–Off Delay Time                                   |  |     | 14             | 24             | ns                         |
| $t_f$   | Turn–Off Fall Time                                    |  |     | 5              | 10             | ns                         |
| $Q_{g(TOT)}$  | Total Gate Charge at $V_{GS} = 10\text{ V}$           | $V_{DD} = 15\text{ V}, I_D = 10\text{ A}, V_{GS} = 5\text{ V}$   |     | 10             | 14             | nC                         |
| $Q_g$   | Total Gate Charge at $V_{GS} = 5\text{ V}$            |  |     | 6              | 8              | nC                         |
| $Q_{gs}$  | Gate–Source Charge                                    |  |     | 1.5            |                | nC                         |
| $Q_{gd}$  | Gate–Drain Charge                                     |  |     | 2.0            |                | nC                         |
| <b>Drain–Source Diode Characteristics and Maximum Ratings</b> |   |  |     |                |                |                            |
| $I_S$   | Maximum Continuous Drain–Source Diode Forward Current |  |     |                | 2.9            | A                          |
| $V_{SD}$  | Drain–Source Diode Forward Voltage                    | $V_{GS} = 0\text{ V}, I_S = 2.3\text{ A}$ (Note 2)   |     | 0.6            | 0.7            | V                          |
| $t_{rr}$  | Diode Reverse Recovery Time                           | $I_F = 10\text{ A},$   |     | 18             |                | ns                         |
| $Q_{rr}$  | Diode Reverse Recovery Charge                         | $dI_F/dt = 300\text{ A}/\mu\text{s}$ (Note 3)  |     | 11             |                | nC                         |

**Notes:**

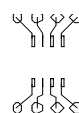
1.  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a) 78°C/W when mounted on a 0.5 in<sup>2</sup> pad of 2 oz copper



b) 125°C/W when mounted on a 0.02 in<sup>2</sup> pad of 2 oz copper



c) 135°C/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300μs, Duty Cycle < 2.0%
3. See "SyncFET Schottky body diode characteristics" below.
4. FDS6990AS\_NL is a lead free product. The FDS6990AS\_NL marking will appear on the reel label.

## Typical Characteristics

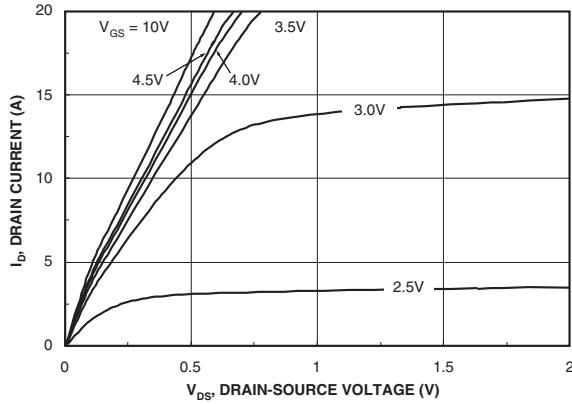


Figure 1. On-Region Characteristics.

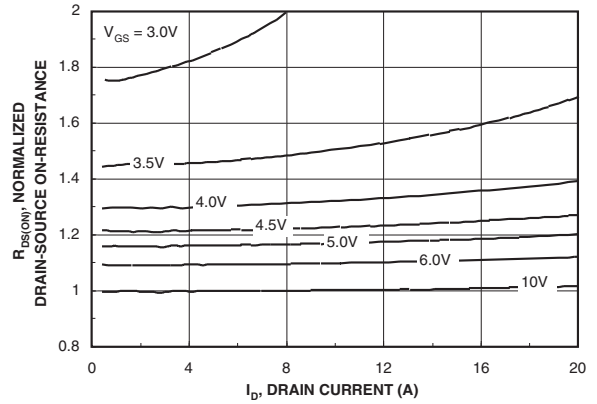


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

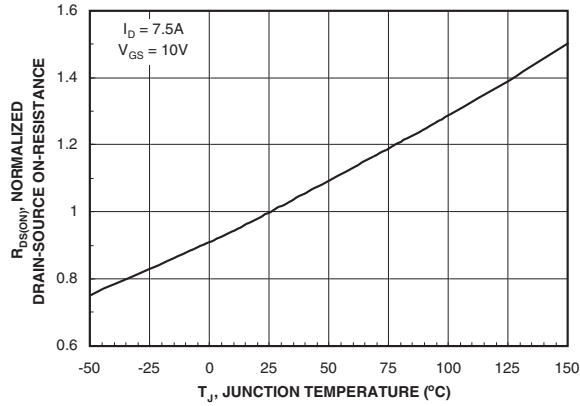


Figure 3. On-Resistance Variation with Temperature.

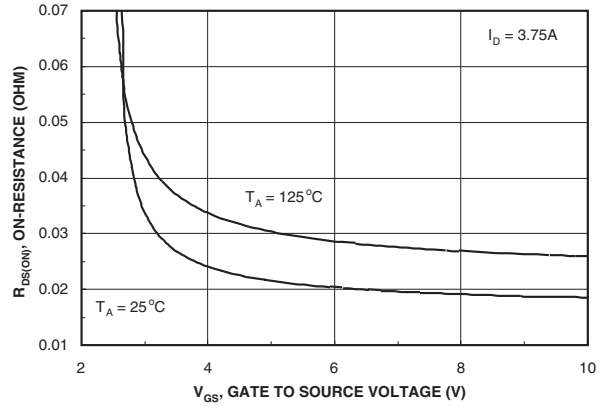


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

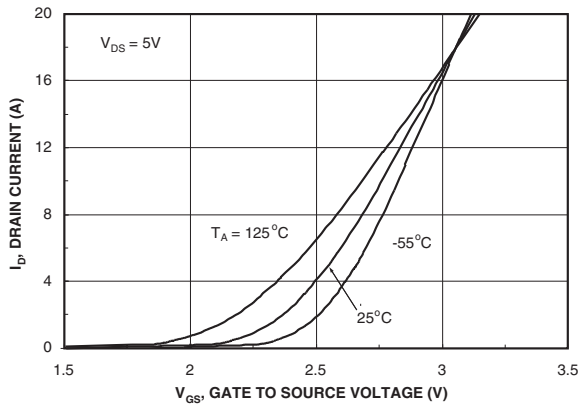


Figure 5. Transfer Characteristics.

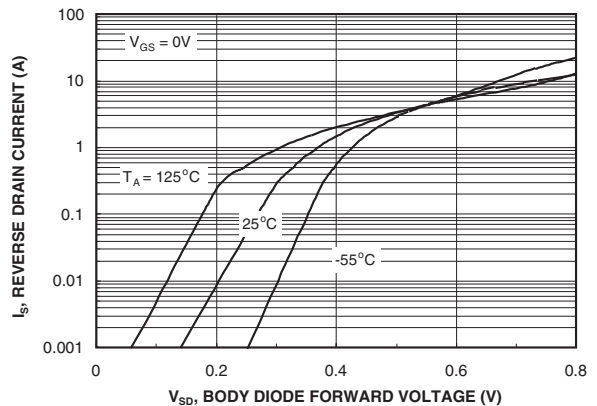
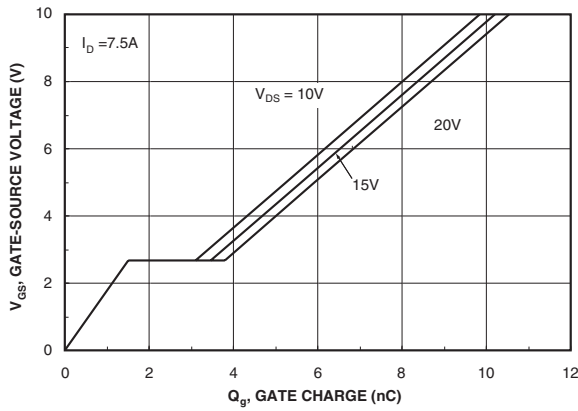
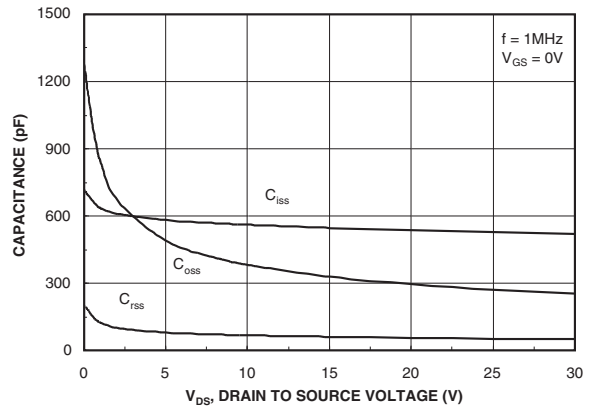


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

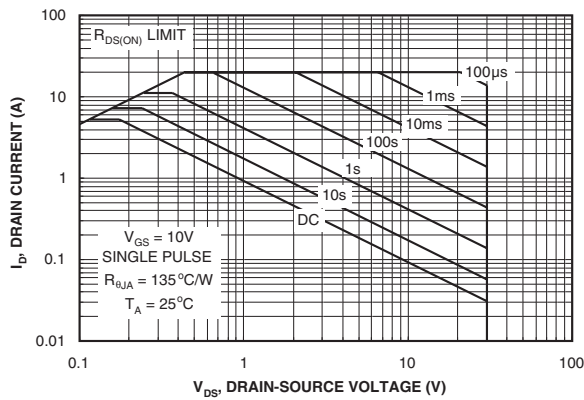
### Typical Characteristics



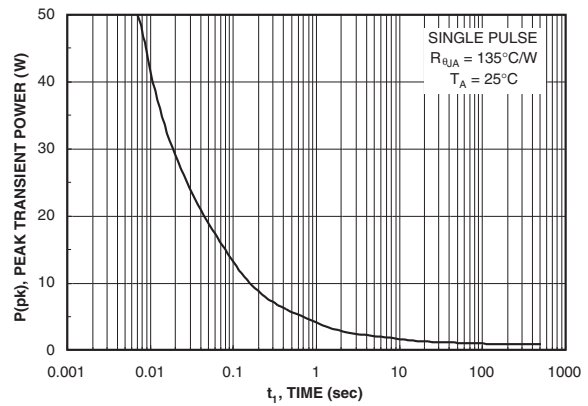
**Figure 7. Gate Charge Characteristics.**



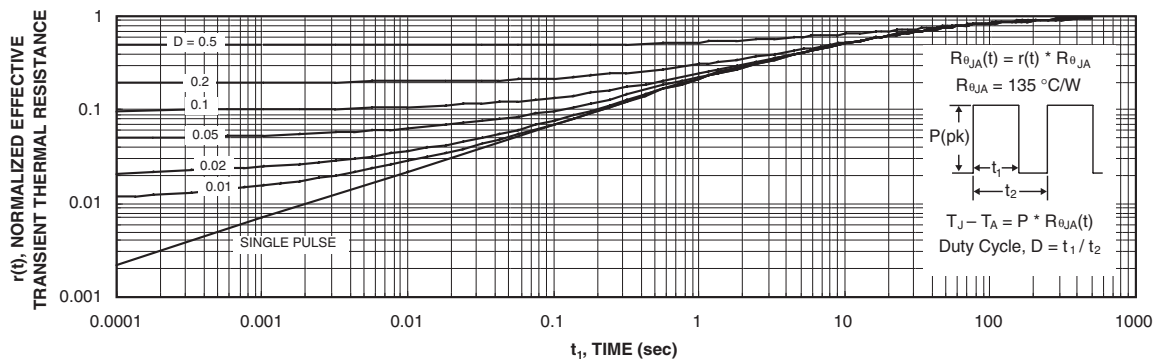
**Figure 8. Capacitance Characteristics.**



**Figure 9. Maximum Safe Operating Area.**



**Figure 10. Single Pulse Maximum Power Dissipation.**



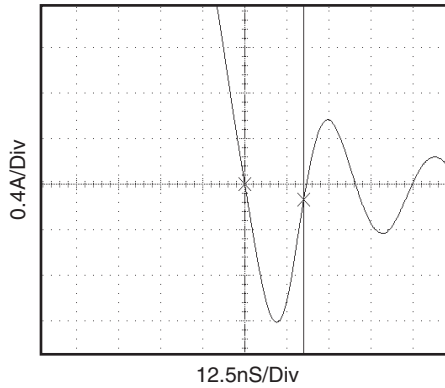
**Figure 11. Transient Thermal Response Curve.**

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

## Typical Characteristics (continued)

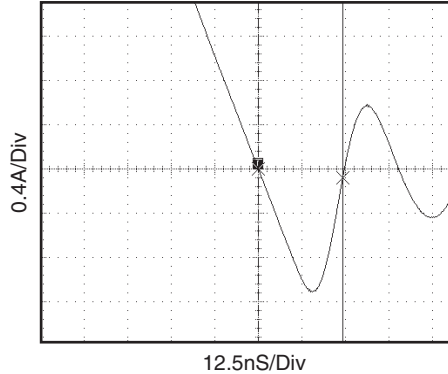
### SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 12 shows the reverse recovery characteristic of the FDS6990AS.



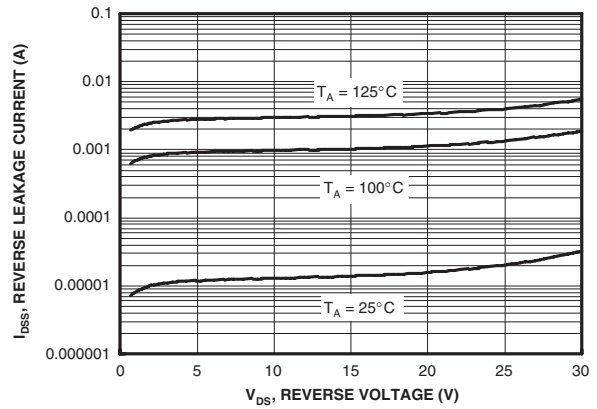
**Figure 12. FDS6990AS SyncFET body diode reverse recovery characteristic.**

For comparison purposes, Figure 13 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDS6990A).



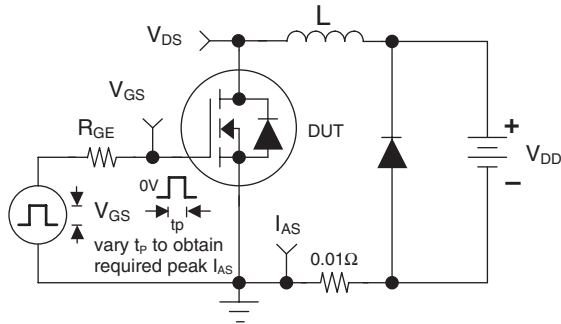
**Figure 13. Non-SyncFET (FDS6990A) body diode reverse recovery characteristic.**

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

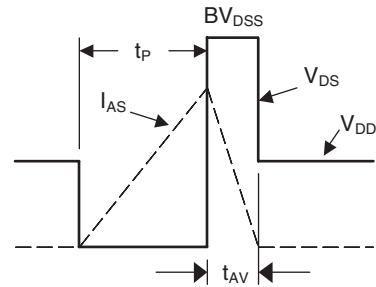


**Figure 14. SyncFET body diode reverse leakage versus drain-source voltage and temperature.**

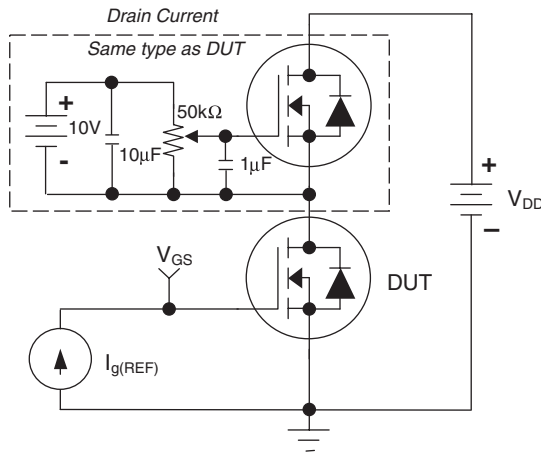
**Typical Characteristics** (continued)



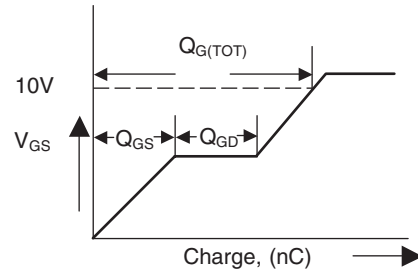
**Figure 15. Unclamped Inductive Load Test Circuit**



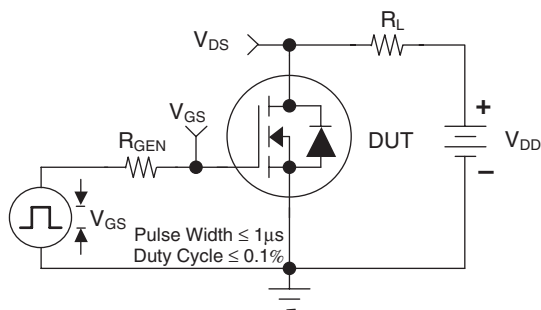
**Figure 16. Unclamped Inductive Waveforms**



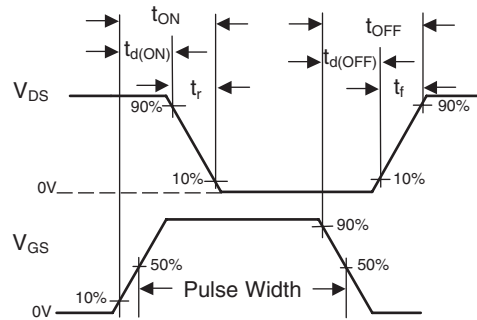
**Figure 17. Gate Charge Test Circuit**



**Figure 18. Gate Charge Waveform**



**Figure 19. Switching Time Test Circuit**



**Figure 20. Switching Time Waveforms**

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| Bottomless™                          | FPS™                | LittleFET™    | PowerEdge™          | SuperFET™       |
| CoolFET™                             | FRFET™              | MICROCOUPLER™ | PowerSaver™         | SuperSOT™-3     |
| CROSSVOLT™                           | GlobalOptoisolator™ | MicroFET™     | PowerTrench®        | SuperSOT™-6     |
| DOME™                                | GTO™                | MicroPak™     | QFET®               | SuperSOT™-8     |
| EcoSPARK™                            | HiSeC™              | MICROWIRE™    | QS™                 | SyncFET™        |
| E <sup>2</sup> CMOS™                 | PC™                 | MSX™          | QT Optoelectronics™ | TinyLogic®      |
| EnSigna™                             | i-Lo™               | MSXPro™       | Quiet Series™       | TINYOPTO™       |
| FACT™                                | ImpliedDisconnect™  | OCX™          | RapidConfigure™     | TruTranslation™ |
| FACT Quiet Series™                   |                     | OCXPro™       | RapidConnect™       | UHC™            |
| Across the board. Around the world.™ |                     | OPTOLOGIC®    | µSerDes™            | UltraFET®       |
| The Power Franchise®                 |                     | OPTOPLANAR™   | SILENT SWITCHER®    | UniFET™         |
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## PRODUCT STATUS DEFINITIONS

### Definition of Terms

| Datasheet Identification | Product Status         | Definition  |
|--------------------------|------------------------|---|
| Advance Information      | Formative or In Design | This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.  |
| Preliminary              | First Production       | This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design. |
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